

Search Notes

Application/Control No.

10/645,815

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

BOUTAGHOU ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
Updated		8/11/2006	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR